

North South University Department of Electrical & Computer Engineering

LAB REPORT Spring 2021

Course Code: EEE 111

Course Title: Analog Electronics - I

Section: 7

Experiment Number: 07

Experiment Name:

Study of Switching Characteristics

Experiment Date: 27 / 04 / 2021

Date of Submission: 03 / 05 / 2021

Course Instructor: Syeda Sarita Hassan

Submitted To: Fatema Zahra

Name of experiment:

Study of switching Characteristics

Objective o

Study all OF the switching characteristics.

Equipments And Components:

- 1) MOSFET TRF 540 I piece each
- 2) Resiston IKA I piece each
- 3) POT ______ lwn+
- 4) Toraineon Board Lunit
- 5) De Power Supply ______ Desirt 2 unit
- 6) Digital Multimeter lunit
- 7) Chords & withe _____ as thequired

(O. F.9)

Theosy:

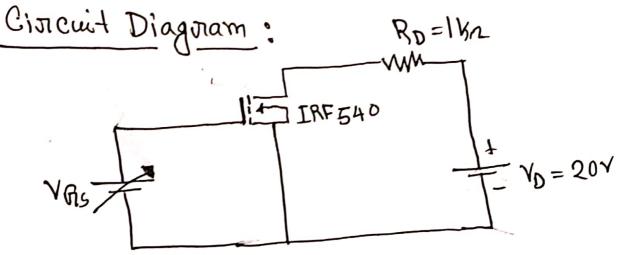
MOSFET (Metal Oxide semiconduction Field EFFect Transistans) belongs to the group OF insulated gate field effect transistan. Mosfets has three terminal gete (n), source (s) and drain (D).

There are two types of MOSFET

i) DE-MOSFET

11) EN-MOSPET

A common application of MOSFET is switching in analog and digital Cincuits.



tables:

| YDD = 420V | | | | √00= 200/ 121 | | | |
|--------------|-----------|-----------|-------------------|--------------------------|--------|---------|--------------|
| V 105 | \sqrt{De} | YL. | $I_{\mathcal{D}}$ | Yous | VDS | VL | ID |
| 0 4 | 201 | -20.13LV | | 04 | 154 | -15.1,1 | 15.27A |
| 0.5 v | 201 | -20.1314 | 20,606 MA | 0.5 | 154 | -15.ly | |
| 17 | 201 | -20.132,0 | 20.606 | ١٧ | 151 | -15. LV | 15.27 n A |
| 2.51 | 7.1451 | -12.851 | | 2.5 | 2.41~ | -12.58 | 12.58 |
| 34 | 0.247 | -19.75v | 19.75 AM | 3√ | VF1.0 | -H.82 | 4.82 WA |
| 4, | 0.124 | ~\J.87\ | 78.01 | 42 | 0.091/ | - 14.69 | 14.02mg |
| 5 1 | O . 09 √ | -19.90 | 19.90 mA | 54 | 0.067 | -14.93 | |

Answer & Question:

DAns: The simulation has been ablached to the lab oreport.

Discussions

In the expeniment we have learned about the switching characteristics of MOSFET We learned now increasing the gate voltage effects the cincuit. The multisim simulation was easy. I didn't face any major difficult

